

INSTRUCTION MANUAL
ISOPROBE® ELECTROSTATIC VOLTMETER
MODEL 279

Equipment Included:

Line Cord
Manual
Probe Cover Plug

279/100 P/N 0340112
110309



PRODUCT WARRANTY

Monroe Electronics, Inc., warrants to the Owners, this instrument to be free from defects in material and workmanship for a period of two years after shipment from the factory. This warranty is applicable to the original purchaser only.

Liability under this warranty is limited to service, adjustment or replacement of defective parts (other than tubes, fuses or batteries) on any instrument or sub-assembly returned to the factory for this purpose, transportation prepaid.

This warranty does not apply to instruments or sub-assemblies subjected to abuse, abnormal operating conditions, or unauthorized repair or modification.

Since Monroe Electronics, Inc. has no control over conditions of use, no warranty is made or implied as to the suitability of our product for the customer's intended use.

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RETURN POLICIES AND PROCEDURES FACTORY REPAIR

Return authorization is required for factory repair work. Material being returned to the factory for repair must have a *Return Material Authorization* number. To obtain an RMA number, call 585-765-2254 and ask for Customer Service.

Material returned to the factory for warranty repair should be accompanied by a copy of a dated invoice or bill of sale, which serves as a proof of purchase for the material. Serial numbers and date codes on our products also serve to determine warranty status. Removal of these labels or tags may result in voiding a product's warranty.

Repairs will be returned promptly. Repairs are normally returned to the customer by UPS within 10 to 15 working days after receipt by Monroe Electronics, Inc. Return (to the customer) UPS charges will be paid by Monroe Electronics on warranty work. Return (to the customer) UPS charges will be prepaid and added to invoice for out-of-warranty repair work.

RETURN OF REPAIRED ITEMS:

Factory repairs will be returned to the customer by the customer's choice of FedEx, DHL or UPS. Warranty repairs will be returned via UPS ground. The customer may request accelerated shipping via the previous mentioned carriers for both warranty and non-warranty repairs. **NOTE:** Accelerated transportation expenses for all factory repairs will always be at the expense of the customer despite the warranty status of the equipment.

FACTORY REPAIRS TO MODIFIED EQUIPMENT:

Material returned to the factory for repair that has been modified will not be tested unless the nature and purpose of the modification is understood by us and does not render the equipment untestable at our repair facility. We will reserve the right to deny service to any modified equipment returned to the factory for repair regardless of the warranty status of the equipment.

MODEL 279

ISOPROBE[®] ELECTROSTATIC VOLTMETER

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SECTION 1

SPECIFICATIONS

A. **Applications:**

Model 279 ISOPROBE[®] ELECTROSTATIC VOLTMETER takes advantage of Monroe's years of experience in design of reliable instruments for **NON-CONTACTING measurement of electrostatic potential** combined with modern semiconductor technology. A full spectrum of proven-design interchangeable probes exposes broad new areas for exploratory research as well as providing a precision instrument for routine applications in electrostatic measurements. Some typical and potential applications include:

- Electrophotographic and xerographic measurements
- IC manufacturing and handling
- Materials evaluation
- Electret research
- Static electrification, electric field studies
- Process monitoring and control

B. **Features:**

- Low profile half rack size for multi-channel applications
- Full complement of interchangeable probes
- Selectable recorder output range
- LED meter with "blackout switch" for darkroom applications

C. **Range:**

0 to ± 3000 volts DC

D. **Accuracy:***

0.1% of full scale, $\pm 0.003\%/^{\circ}\text{C}$ over +20 to +40 $^{\circ}\text{C}$ range (at recorder output). Useable to +50 $^{\circ}\text{C}$.

E. **Speed of response:***

For typical input step:	<3ms	(10% to 90%)
for 1kV step:	<2½ms	(10% to 90%)
for 2kV step:	<3½ms	(10% to 90%)
for 3kV step:	<4ms	(10% to 90%)

F. **Settling time:**

<6½ms to 1% of final value.

G. **Frequency response:**

Small signal frequency response typically $\pm 3\text{db}$ to >300Hz.

H. **Drift:***

<0.01V/hr after 1 hr stabilization (0.003V/hr typical). Not measurably affected by 10 $^{\circ}\text{C}$ temperature variation or changes between 10% and 90% relative humidity.

I. Noise:*

<0.3mV rms or 3 millivolts peak-to-peak wide band at 1/1000 output.

J. Surface resolution:

Determined by probe aperture size and surface-probe separation. Standard type 1034E & S probes with 0.07" (1.75mm) aperture will resolve a 0.10" (2.5mm) spot at 0.02" (0.5mm) separation.

K. Recorder output:

Compressed analog output is input divided by 1000 (standard) or 100 or 200 (factory selectable)
Typical maximum dynamic range at isolated BNC connector is ± 18 volts for external loads greater than 10k Ω .

L. Output filter:

Bessel low pass filter with 1.2ms constant delay.

M. Size:

1.7 x 8.2 x 15.1 inches (44 x 208 x 384mm), 1.75" rack mounting available (1 or 2 per rack).
Weight 4 lb. (1.8kg).

N. Power requirement:

100, 120, 230 or 240 VAC, $\pm 10\%$, 50/60Hz, 15 watts.
Fuse $\frac{1}{4}$ A SB for 100 & 120 V (Littelfuse 313.250 or equiv.)
Fuse $\frac{1}{8}$ A 5x2mm for 230 & 240 V (Littelfuse 217.125 or equiv.)

* Dependent on specific probe model, probe-to-surface separation and environment. Specifications shown are for standard Type 1034E or S probes in a normal laboratory atmosphere. Separation for accuracy and response speed tests is $\frac{1}{8}$ " (3mm) and for noise and drift tests, 0.005" (0.13mm). Performance generally improves in controlled environments and may be degraded under exceptionally dirty or dusty conditions or in ambiance of unstable gaseous constituents.

PROBES:

Monroe Electronics Type 1034E (end viewing) or 1034S (side-viewing) probes are 0.35" (9mm) x 0.35" (9mm) x 3.25" (82.6mm) in length. Add 0.8" (20mm) length for cable at minimum bend radius. Contains 1kHz tuning fork chopping driver and onboard hybrid microcircuit preamp. Useable from -50°C to +80°C. Optional probe configurations are available for high or low resolution and transparent probes for light decay measurements. Length of probe cable is 10 ft. (3.05 meters). Provision has been made for air or inert gas purging of probe. Standard basic instrument package includes Model 279 electrostatic voltmeter, line cord and instruction manual. Rear mounted connector on instrument is standard; front panel connector is optional. Unit is calibrated independent of probe and includes certificate of NIST traceability. Interchangeable Model 1034 probe (type specified by customer) is sold separately.

SECTION 2

INSTALLATION

CAUTION:

Before plugging instrument in, make certain that it is matched to local power line voltage. The factory set line voltage may be determined by the position of the voltage selector indicator pin in the power entry module. All units are shipped configured for 120 VAC unless otherwise specified. In the event that it is necessary to change the operating voltage of the instrument (or inspect or replace the fuses), see Appendix II for more information.

NOTE:

Wire Color Code for Line Cord Provided.

HIGH SIDE OF LINE - BLACK or BROWN
LOW SIDE OF LINE - WHITE or LIGHT BLUE
SAFETY GROUND - GREEN or GREEN/YELLOW

A. Probe mounting:

The 1034 and all other compatible probes must be mounted with the sensitive aperture facing the surface to be measured.

The probe must be electrically isolated for up to 3400V, since the probe acquires the potential of the surface being measured.

Further probe mounting information is given in Appendix I.

B. Probe-to-surface spacing:

CAUTION:

When operating at probe-to-surface spacing of less than 0.125 inches (3mm) -- BEWARE OF PROBE-TO-SURFACE ARC-OVER. Refer to Appendix III for further information.

Probe to surface spacing should be maintained as close as physically reasonable for best performance. Typical spacing range is from .005" (0.1mm) for unknown voltages below 500 volts to over .125" (3mm) for unknown voltages up to 3000 volts.

As probe to surface spacing increases instrument performance will suffer:

1. Decreased Accuracy
2. Decreased Speed-of-Response
3. Decreased Surface Resolution
4. Increased Noise
5. Increased Drift

C. System grounding:

The instrument is normally grounded via power cord and the potential measured is referenced to ground. A rear panel ground connection is provided.

D. Output circuitry:

The output connector is a BNC connector mounted to the rear panel. The output voltage unless otherwise specified is the measured voltage divided by 1000. Normal useable output range is $\pm 3V$.

E. Probe purging:

Probe purging improves instrument performance especially with regard to zero stability, noise and sensitivity to variations in probe-to-surface spacing. An optional purge kit available from Monroe Electronics maintains an even airflow, reduces temperature variations and filters out dust and other particles.

Contact potential is a function of these variables and should be considered when making any changes in the purging techniques. Care should be taken to maintain the purged air as free from chemical vapor contamination as possible.

Probes may also be purged using clean, dry oil-free air from a local source or through the use of dry nitrogen or other inert gas. Pressure needs only be sufficient to maintain a positive flow of gas out of the sensitive aperture to prevent foreign materials from entering and, in no case should it exceed ½ psi (14" w.c.). All materials used should have low out-gassing properties.

For best results, leave purge in continuous operation. For long term storage, cover the end of the probe with the plastic cap supplied or with aluminum foil to seal against contamination.

SECTION 3

CONTROLS AND INDICATORS

FRONT PANEL - Figure 3-1

A. STBY/OPER Switch:

This push-push switch controls the operating condition of the unit. So long as power is applied, the following is true:

STANDBY — Starts the probe oscillating but leaves the high voltage disabled.

OPERATE — Activates high voltage only if the probe is plugged in and the tuning fork is oscillating.

B. Display:

The 4½-digit LED display is normally illuminated when power is applied to the unit and acts in a secondary capacity as a power indicator.

A minus (-) sign at the left side of the display indicates that a negative voltage is being measured and is displayed approximately 50% of the time (a polarity indecision) when the instrument is properly zeroed while measuring an input signal of zero. No sign is displayed for a positive input.

The display may be turned off for darkroom use by actuating the push-push display switch through the access hole in the panel with a suitable tool such as the point of a pen.

C. ZERO 1:

Balances internal probe contact potential to obtain probe to surface spacing insensitivity. This adjustment procedure is described in Section 4A. ZERO 1 may also be used for large zero offset when spacing insensitivity is not needed.

D. GAIN:

Closed loop system gain varies with probe to surface spacing. Excessive gain at close spacing causes instability and insufficient gain at large spacing produces sluggish response and static error.

E. ZERO 2:

Compensates for unwanted system offsets over a range of approximately ± 4 volts and does not affect probe to surface spacing insensitivity. Adjustment procedure is outlined in Section 4. Once set, this operator accessible adjustment usually does not require further attention except in critical applications.

F. Probe receptacle:

Mates with Model 1034 series probes manufactured by Monroe Electronics. An appropriate and functional probe must be connected for the instrument to operate.

To connect the probe to the instrument, hold the plug (on probe cable) so that the two arrows are on top. Align with the receptacle and push straight in until a "click" is heard.

To disconnect, hold the part with the two arrows and pull straight out. This will release the locking device.

Do not connect or disconnect the probe with power applied.

REAR PANEL - Figure 3-2

G. Power Entry Module:

The Power Entry Module combines power inlet, switch and fusing system. Power supply voltage is usually factory preset for local conditions. *When in doubt, check!* See Appendix II for details.

H. Ground jack:

Instrument ground - the reference point for measurement. The instrument is normally grounded through the power cord. This jack accepts a standard size banana plug (0.175" [4.4mm] across flats).

I. Recorder output:

The signal at this BNC jack is a low voltage representation of the input. The output voltage is equal to the measured voltage measured divided by 1000 or 0 to ± 3 volts for full scale (± 17 volts full scale typical for ± 200 option and ± 19 volts full scale typical for ± 100 option). Representative uses include observation or recording of waveforms or levels seen by the input, monitoring of safe/unsafe electrostatic operating conditions in equipment and low level process control in electrostatic feedback loops.

J. Probe receptacle:

Duplicate of (F) provides the option of a probe connection at the rear of the instrument. **Only one or the other may be used. Model 279 will not support two probes simultaneously.**

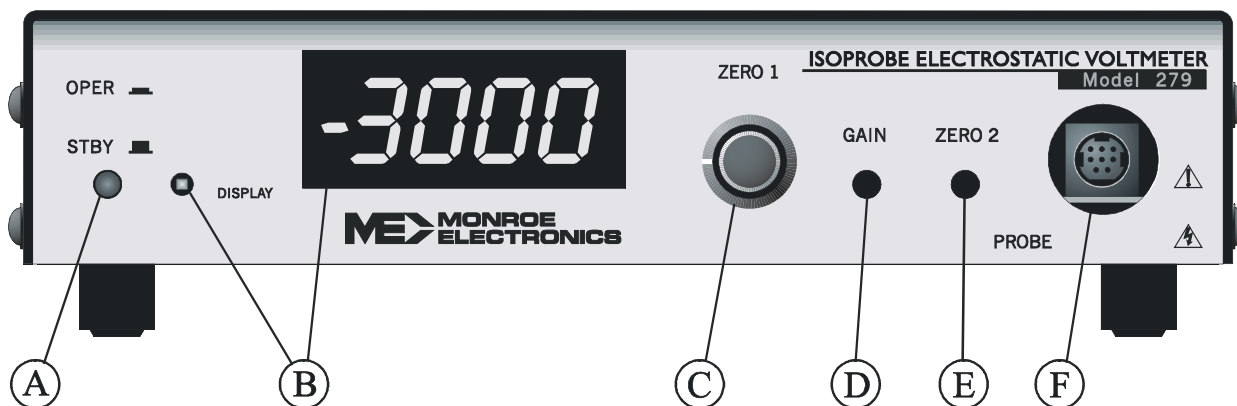


Figure 3-1

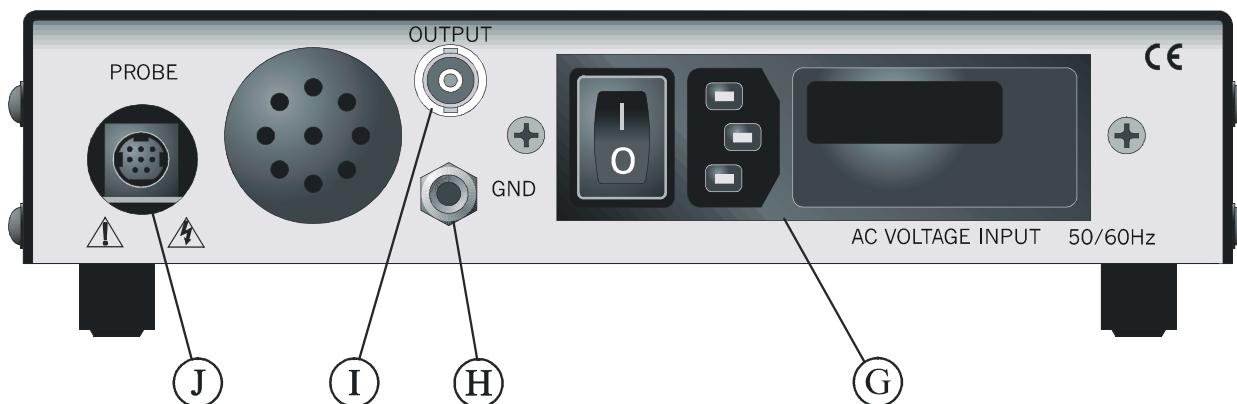


Figure 3-2

SECTION 4

OPERATION

CAUTION:

Verify that instrument operating voltage matches local power line voltage. Refer to power connector on rear panel to verify voltage the instrument is set for.

PRECAUTIONARY NOTE

Model 279 is a non-contacting voltmeter. The potential of the probe will attempt to follow the potential of any object within the field of view of the sensitive electrode (up to ± 3400 volts) when the instrument is operating. In the interest of operator safety and also to reduce high voltage stress within the instrument, it should be left in the STANDBY mode whenever it is not being used and particularly when the probe will not be "looking" at a surface potential of less than 3000V.

A. Initial setup:

As shipped from the factory, the instrument is set up to make general-purpose electrostatic measurements except for zero adjustment.

1. Position probe approximately $\frac{1}{8}$ " from a grounded surface.
2. Switch into OPERATE mode.
3. Adjust ZERO 1 for an indication of 0000 on meter.
4. Proceed with measurements.

B. Restoration of factory settings:

The following steps are necessary only if the factory settings of ZERO 2 and/or GAIN controls have been disturbed as evidenced by a constant zero offset or unstable performance at close probe to surface spacing.

ZERO 2

1. With the probe positioned as above, switch into STANDBY mode.
2. Adjust ZERO 2 for an indication of 0000 with approximately 50% polarity indecision.

GAIN

This adjustment requires a metallic test surface at least 3- 4 inches (50-75mm) square and a means of applying repetitive pulses or square waves to it. Amplitude should be in the order of 100-300 volts with a rise time significantly better than 2 milliseconds. An oscilloscope is also required.

1. Set GAIN to maximum counterclockwise (CCW) rotation.
2. Position probe 0.005" (0.13mm) from the test surface.
3. Apply repetitive pulses to the test surface while observing the output of the 279.
4. Adjust GAIN for optimized transient response (fastest rise time with minimum overshoot and no oscillatory tendency).

SECTION 5

THEORY

A. General: Principle of Operation (See Figure 5-1)

The electrostatic electrode "looks" at the surface under measurement through a small hole at the base of the probe assembly. The chopped AC signal induced on this electrode is proportional to the differential voltage between the surface under measurement and the probe assembly. Its phase is dictated by the DC polarity.

The reference voltage and this mechanically modulated signal, conditioned by the high input impedance preamplifier and signal amplifier are fed to a phase sensitive detector whose output DC magnitude and polarity are dictated by the amplitude and phase of the electrostatically induced signal relative to the reference signal. The output of the phase sensitive detector feeds a DC integrating amplifier. Its output polarity is inverted to that of the unknown. The output of this amplifier is used to drive a high voltage amplifier, which in turn drives the probe to the same potential as that of the surface under measurement.

The probe is driven to a DC voltage typically within 0.1% of the potential of the unknown for a 2-3mm probe-to-surface spacing. By simply metering the output of the H.V. amplifier, one has an accurate indication of the unknown potential.

**ISOPROBE® ELECTROSTATIC VOLTMETER
Model 279
Simplified Block Diagram**

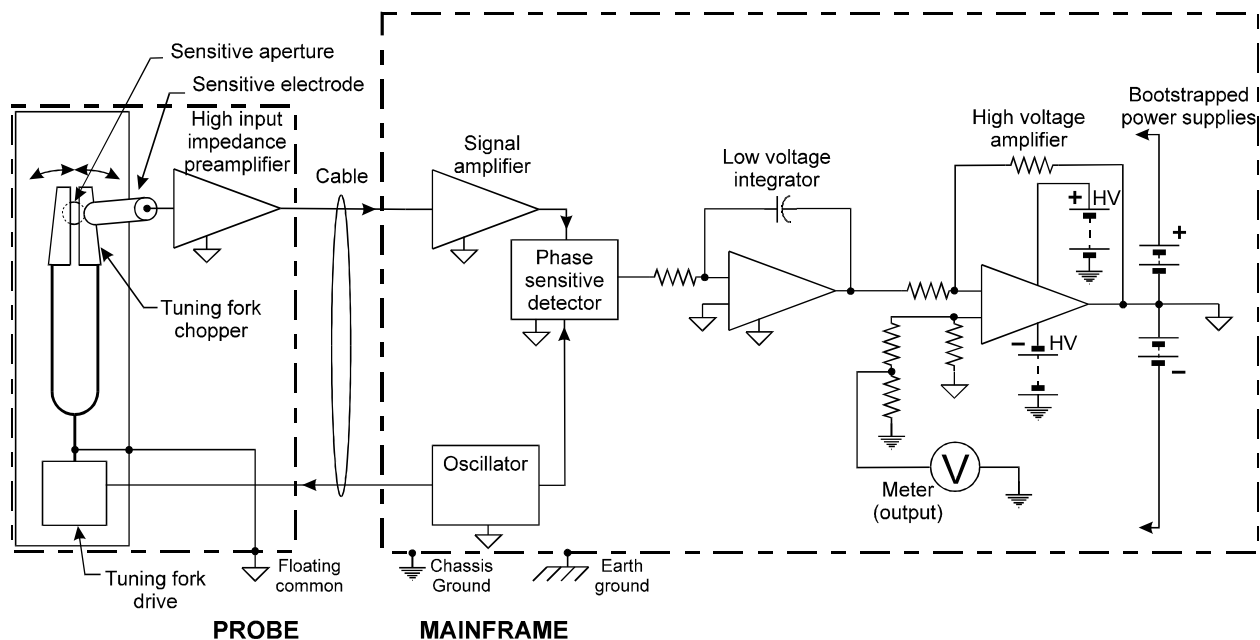


Figure 5-1

B. Null balance: (ZERO 1)

This instrument's basic operating principle, i.e., "field-nulling" provides a high degree of immunity to errors in measurement caused by variations in probe-to-surface separation. As long as the probe and the surface under measurement are at the same potential the electrical field between them is zero, neglecting fringing, regardless of the probe-to-surface distance.

If, however there exist voltage sources in the vicinity of the sensitive electrode which are independent of the unknown to be measured, the offsets produced will detrimentally affect the spacing independence. Such voltage sources include contact potential differences among the internal probes parts, small specks of charged dust particles, etc.

The null balance circuitry is provided to neutralize such offsets by applying a voltage directly to the sensitive electrode.

C. Zero: (ZERO 2)

The instrument's zero control is a voltage source connected in the metering circuitry. It is used to overcome offsets produced by voltage sources external to the probe.

D. Gain:

The instrument functions as a closed loop unity gain voltage follower. Its open loop gain from probe to integrator is determined by the gain of various amplifiers. The exact gain required for optimum transient responses during a specific measurement is determined by the probe-to-surface spacing used. In order to accommodate measurements at various probe-to-surface separations, a front panel gain control is provided which controls the gain of the signal amplifier.

SECTION 6

ADJUSTMENT

A. General:

The following procedure sequence is such that it will aid in troubleshooting the unit. The circuit board layout is illustrated in 3570/22. All test points and reference numbers used in this section are indicated on schematic 279/1, assembly drawing 3570/22 and are identified in Table 6-2 at the end of this section.

The procedure should be followed in the order given to prevent possible interaction of controls.

A phase-compensated (normal) Monroe Electronics, Inc. Model 1034E or 1034S miniature probe must be used wherever the use of a probe is indicated.

B. Recommended Equipment:

Oscilloscope – 50kHz bandwidth, 0.1mV/div sensitivity

Compensated high voltage probe for oscilloscope (optional)

High voltage source – ± 3 kV, Stanford Research Systems Model PS350 or equivalent

Digital voltmeter – five-digit, 0.1mV resolution

High voltage probe – 1000:1, $\pm 0.01\%$ (for DVM)

Shorting plug, ME P/N 9232301, Keystone P/N 1463 (used at JP8)

C. Initial Setup and Adjustments:

1. Insure that available nominal power line voltage and frequency match those indicated of the back panel of the unit. **Do not apply power at this time.**
2. Remove cover from unit.
3. Consult Table 6-2. Make the following potentiometer adjustments: Set R53, R54, R108 and R111 to midrange. Set R8, R55 and R56 counterclockwise. Set R107 clockwise.
4. Connect a probe to the rear panel connector and fixture it to look at a metal test plate at least six inches (150mm) square at a distance of 0.005 inch (0,13mm).
5. Connect a high voltage source to the test plate and set its output for zero volts.
6. Install a shorting plug at JP8 and disconnect JP13. Jumpers JP1, JP3, JP4, JP6, and JP7 should be installed.
7. On the front panel, put the OPER/STBY switch in STBY and turn on the display.
8. Connect the 279 to the appropriate source of power and turn on the rear panel power switch.

D. Low Voltage Power Supply Check:

Check the following test points with a digital voltmeter between the test point and chassis.

Test Point	D.V.M. Reading
TP15	-15 VDC ± 0.5 V
TP16	+15 VDC ± 0.5 V
TP18	+15 VDC ± 0.5 V
TP20	-15 VDC ± 0.5 V

Table 6-1

E. Probe Oscillator Adjustment:

Connect an oscilloscope probe to TP5 and adjust R53 for a 6 Vp-p sine wave.

F. Demodulator Phase Adjustment:

1. Move the oscilloscope probe to TP3 and adjust the ZERO 1 pot on the front panel for a null (straight line) on the oscilloscope.
2. Apply +10V to the test plate and adjust R65 for the best representation of a negative going half-wave rectified sine wave with an amplitude of about 0.5V.
3. Switch the test plate voltage to -10V and the oscilloscope should display a positive going half wave.

G. FET String Bias Adjustment:

1. Switch off the rear panel power switch.
2. Remove JP4.
3. Tie TP8 to TP6.
4. Connect a DVM between TP1 of the N-FET board and the chassis. The N-FET board is the inner FET board and TP1 is the only test point on it.
5. Connect JP13. **WARNING! When the power is on, high voltage will be present on the high voltage rectifier and at the rear of the FET boards.**
6. Switch on the rear panel power switch.
7. Adjust R55 for 40mV on the DVM.
8. Move the DVM input lead to TP1 on the P-FET board.
9. Adjust R56 to match the N-FET bias reading. Switch off the rear panel power switch.

H. High Voltage Adjustment:

1. Remove the ground from TP8.
2. Remove the jumper at JP8.
3. Replace jumper JP4.
4. Increase the probe to test plate spacing to 1/8" (3,2mm).
5. Connect a DVM low side to TP11 (37V-) and high side to TP10 (37V+).
6. With the operate switch in STBY, turn on the power.
7. Adjust R8 for +37.0V on the DVM. NOTE: This is a differential measurement.
8. Switch off the power.
9. Remove the DVM leads from TP10 and TP11.
10. Connect the 1000:1 high voltage probe to the high voltage pin at the rear of the N-FET board.
11. Switch the power on and the DVM should read about +3900V.
12. Repeat steps 10 and 11 for the P-FET board and the DVM should read about -3900V.
13. Remove the high voltage probe.

I. Speed of Response:

1. Check that the probe to test plate spacing is still 1/8" (3,2mm).
2. Set the gain pot, front panel recessed, for about midrange.
3. Connect the oscilloscope to the rear panel output connector.
4. With the 279 in standby, STBY/OPER switch out, check the range of the ZERO 2 pot on the front panel meter. It should swing plus and minus with a total of about 10V. Zero the front panel meter with ZERO 2.
5. Push the operate switch and then zero the front panel meter with the ZERO 1 pot on the front panel.
6. Apply a repetitive +1kV pulse to the test plate.
7. Adjust the gain pot, the integrator gain pot (R54) and the oscilloscope controls until a critically damped step response between 0% and 100% is observed. Rise and fall times from 10% to 90% should be 2.5ms or less.
8. Repeat for +2kv. The 10% to 90% response time should be 3.5ms or less.
9. Repeat for +3kv. The 10% to 90% response time should be 4ms or less.
10. Check the response to negative steps in a similar manner. Switch to standby.

J. Noise Check:

1. Set the probe to test plate spacing to 0.005" (0,13mm).
2. Reduce the gain to just up from counter clockwise. Switch to operate.
3. Pulse the test plate with +100 volt pulses.
4. Adjust the gain and oscilloscope controls for a critically damped transient response.
5. Replace the oscilloscope with an rms voltmeter. Noise is typically 0.3mV rms.

K. Output Calibration:

1. Connect the rear panel output connector to a DVM
2. Adjust ZERO 1 for zero volts on the DVM and the front panel meter.
3. Slowly apply voltage to the test plate until it is precisely +3.000kV.
4. The DVM at the output should +3.000V \pm 0.1%. Adjust R5 if necessary to meet this condition.
5. The front panel meter should indicate +3000 \pm 0.1% LSD.
6. Repeat steps 3 through 5 using -3000v.
7. Check calibration at \pm 2kV.
8. Remove the test equipment and replace the cover. This completes the adjustment procedure.

ID	Description	NOTE
JP1	HV TEST	
JP3	VM OPT <i>ion</i>	
JP4		Driver link
JP6		Standard output option selector
JP7		Standard output option selector
JP8	HV JUMPER	Shorting plug, ME P/N 9231029
JP13	3KV	Red wire
R5		1/1000 cal.
R8	SET 37 VDC	
R53	OSC <i>illator</i> LEVEL	
R54	INT <i>egrator</i> GAIN	
R55	+BIAS	
R56	-BIAS	
R65	DEM <i>odulator</i> PHASE	
R107	GAIN	Recessed through front panel
R108	ZERO 1	10 turn pot on front panel with knob
R111	ZERO 2	Recessed through front panel
TP1		*Located on FET boards
TP3	DEM <i>odulator</i> SIG <i>nal</i>	
TP5	CARRI <i>ER</i> REF <i>erence</i> OSC <i>illator</i>	
TP6		Common
TP8		Set bias
TP10	37 V+	
TP11	37 V-	
TP15	-15 VDC	Chassis referenced power supply
TP16	+15 VDC	Chassis referenced power supply
TP18	+15 VDC	Floating power supply
TP20	-15 VDC	Floating power supply

Table 6-2

SECTION 7

TROUBLESHOOTING

PRECAUTIONARY NOTE

Model 279 is a non-contacting voltmeter. The potential of the probe will attempt to follow the potential of any object within the field of view of the sensitive electrode (up to ± 3400 volts) when the instrument is operating. In the interest of operator safety and also to reduce high voltage stress within the instrument, it should be left in the STANDBY mode whenever it is not being used and particularly when the probe will not be “looking” at a surface potential of less than 3000V.

A. **General:**

BEFORE ATTEMPTING TROUBLE-SHOOTING TECHNIQUES, CONSIDER THE FOLLOWING:

1. Attempt to determine mode and cause of failure. If you broke it you probably have some idea how. If someone else did, try to get as many details as possible.
2. Check control settings. Review the CONTROLS and INDICATORS section of this manual.
3. Check power line voltage. Be sure that VOLTAGE SELECTOR is in the correct position. Check fuse.
4. Look for obvious physical damage (charred parts, loose connections, broken solder joints, broken circuit board, etc.)
5. Check calibration. If it appears that the instrument is uncalibrated, review the ADJUSTMENT section of this manual.
6. Always rectify the cause of the problem.

B. **User checklist:**

1. **INDICATION**—Power switch at rear of instrument is ON—no display illumination.
 - a) Check display button recessed behind front panel. Should be latched in to turn display on. See Paragraph 3B.
 - b) Check fuse(s) and line voltage settings. See Appendix II.
2. **INDICATION**—Power switch is ON—no sound from probe. NOTE: A faint 1kHz tone should normally be heard emanating from the tuning fork chopper in the probe.
 - a) Check to be sure that the probe connector is firmly locked in its receptacle.
 - b) Check for physical damage to probe (dents in case, cut cable, dirt or dust inside of aperture) that would prevent the tuning fork from operating.
3. **INDICATION**—Arcing between probe and surface under test.
 - a) GAIN too high at close spacing—system unstable.
 - b) GAIN too low at close spacing—system cannot follow fast high voltage transient
 - c) Surface voltage beyond range of instrument.
4. **INDICATION**—Operator receives shock from probe.
 - a) DO NOT TOUCH metal body of probe while in operation.
 - b) Check for frayed or damaged insulation.
5. **INDICATION**—Unit does not seem “calibrated”.
 - a) There is no “calibration” necessary from an operator standpoint. The instrument is factory calibrated and certified so. Otherwise, calibration is recommended following repairs to the instrument or annually unless more frequent calibration is required by contract.
 - b) Probes are not calibrated; they either work or they don’t work.
 - c) Review the steps in the OPERATION Section, Section 4.

C. Detailed Troubleshooting – Initial Setup:

1. Follow instructions given in Section 6-C; Initial Setup and Adjustments leaving out Step 3 (potentiometer adjustments). **NOTE: The following steps are done with the front panel OPER/STBY switch in STBY.**

D. Low Voltage Power Supplies:

1. With a DVM, check between chassis ground and TP-16 and TP-15 for plus and minus 15 volts. These are the ground referenced (non-floating) supplies for some of the output circuitry. Incorrect readings could indicate trouble at A-1 or A-2 or their associated circuitry or trouble with the supplies themselves, A-9 and A-10 and their associated circuitry.
2. With a DVM, check for plus and minus 15 volts at TP-18 and TP-20. These are the floating supplies for the signal and reference circuits and are supplied from a tap on the high voltage transformer T-1. If 37VDC is measured between TP-10 and TP-11 and +20VDC is measured at the cathode of CR-10 and –20 VDC at the anode of CR-11 and the voltages at TP-18 are incorrect, the trouble is somewhere in the signal or reference circuitry.

E. Reference and Signal Section:

1. With floating common still tied to ground with JP-8 (Section 6-C-6), connect an oscilloscope probe to TP-5. There should be a 6V p-p sine wave of about 1kHz present. The amplitude should be adjustable with R-53. Trouble here usually indicates a defective probe.
2. Move the oscilloscope probe to TP-3. Turn the front panel GAIN pot (R-107) clockwise and zero the display with ZERO 1 pot (R-108). Apply +10 volts to the test plate and the oscilloscope should display a negative-going half wave rectified signal of about 1V p-p. Minus 10 volts on the test plate should produce a positive-going half wave rectified signal of about 1V p-p.
3. If the demodulator signal is incorrect, check for a +15 volt square wave at TP-4 and a 6 volt p-p sine wave at the carrier signal test point TP-2 when 10VDC is applied to the test plate.

F. FET Strings and High Voltage Supply:

1. Trouble in the high voltage section can be isolated to either the FET boards or the high voltage supply.
2. To check the high voltage supply:
 - a) Switch off the rear panel power switch
 - b) Remove the jumper at JP-8
 - c) Remove the two FET boards
 - d) Re-connect JP-13
3. When the power switch is turned back on, about 4000 volts should be present on the FET board pins at the rear of the 279 marked “+HV” for the N-FET string and “–HV” for the P-FET string. If the high voltage is low or absent, the trouble is in T-1 or its rectifier circuitry.
4. If the high voltage is normal, a good indication of the health of the FET strings can be obtained by checking the FET string bias. Refer to ADJUSTMENT Section 6-H.

APPENDIX I

MODEL 1034 PROBE MOUNTING

The Monroe Electronics, Inc. Model 1034 Miniature Probe is intentionally constructed with no mounting devices, as any such mounting device would serve only to enlarge the physical dimensions. It is, therefore, left to the user to devise a method of mounting the probe to suit his individual needs and to realize the fullest potential of the inherently small size.

As supplied, the probe is partially jacketed by a length of irradiated polyolefin shrinkable tubing. This jacket provides insulation of sufficient dielectric strength that the probe may be hand-held or clamped using light pressure for use within the operating range of the Model 279 ISOPROBE[®] Electrostatic Voltmeter.

This tubing is otherwise not essential to the operation of the probe. IT MAY BE REMOVED AND DISCARDED, IF DESIRED. It must, in fact, be removed if the probe is to be disassembled for any purpose such as cleaning (in those procedures involving removal of the case). A sharp model maker's knife may be used to slit the tubing using CAUTION to assure that the cable jacket is not nicked or slit.

If replacement is required, a 2⁵/₈-inch length of ALPHA FIT221-³/₈ or equivalent is recommended. Apply heat only long enough to shrink the tubing in place as damage to the sensitive electronics and adhesives within the probe may result from prolonged elevated temperature on the outside of the case.

When devising fixturing for the Model 1034 probe, consideration must be given to the fact that the normal operating range of the Model 279 ISOPROBE[®] Electrostatic Voltmeter is ± 3000 volts and that the probe assumes the potential of the surface under measurement within these limits. The probe, therefore, must be insulated from other parts of the system.

Choice of insulating materials, although not critical in many applications, should be limited, if possible, to "leaky" dielectric materials with relatively low volume resistivities (in the general order of 10^{10} ohm-cm) as opposed to those such as polystyrene, which is a very good insulator. Example of "leaky" insulators are the phenolics. The primary purpose in this is to provide a discharge path for the insulator which has a short relaxation time. This is especially important in the vicinity of the sensitive aperture.

The Model 279 is capable of driving a capacitive load of several hundred picofarads without severe degradation in performance. It is possible, therefore, to attach the probe to some fixed portion of the apparatus via a metal clamp, so long as the metal clamp is insulated from the remainder of the apparatus.

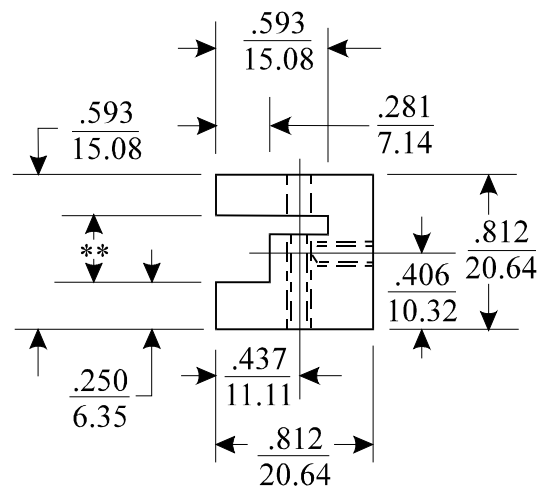
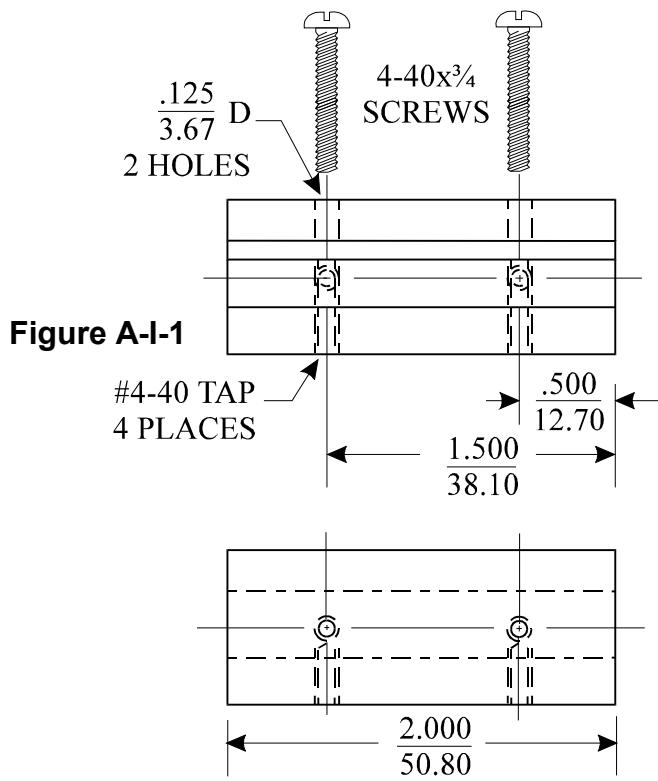
In any friction clamp design, the pressure (unit force) on the probe case should be kept low, thus over as large an area of the case as possible as distortion of the gold plated brass may otherwise occur.

One possible configuration is illustrated in Figure A-I-1.

For general bench use burette or utility clamps attached to a ringstand or similar support may prove adequate. These are available from scientific supply houses.

An attractive alternative to clamping is the use of double sided adhesive tape or fast-setting polymerizing adhesives such as LOCTITE* SuperBonder 495 cyanoacrylate adhesive or equivalent which does not require long setting or curing time and provides a relatively permanent bond. LOCTITE* is a registered trademark of and is available from:

*LOCTITE CORPORATION
Newington, CT 06111
(208) 278-1280



Dimensions are: $\frac{\text{in. } (\pm .010")}{\text{mm. } (\pm .250\text{mm})}$

** is: $\frac{.312", +.002, -.000}{7.92\text{mm.}, +.25, -.00}$

Material - Paper Phenolic

APPENDIX II

POWER ENTRY MODULE

This instrument uses a Corcom, Inc. M Series Power Entry Module that combines a power inlet, switch and fusing system in one compact unit. The IEC 320 power inlet accepts any suitably terminated cordset. The ON/OFF switch is DPST and has international I/O markings. The selectable fuseholder allows use of single or dual European fuses or a single North American fuse. A voltage selector provides a convenient means to change transformer primary connections to interface with worldwide power sources.

An exploded view of the power entry module with its components identified is shown below in Figure A-II-1:

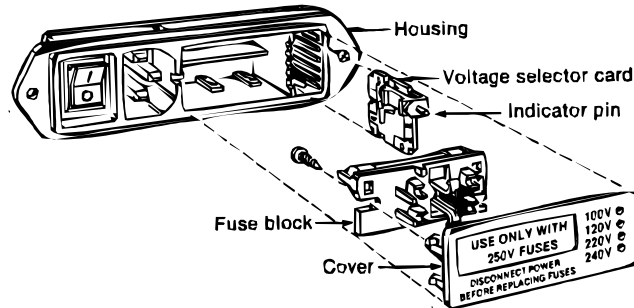


Figure A-II-1

Voltage selection:

The nominal voltage to which the power entry module is set is indicated by the indicator pin visible in one of the holes adjacent the voltage markings.

To change selected voltage: open cover using a small blade screwdriver or similar tool; set aside cover/fuse block assembly; pull voltage selector card straight out of housing using indicator pin; orient selector card so that desired voltage is readable at the bottom; orient indicator pin to point up when desired voltage is readable at the bottom (note that when the indicator pin is fixed; successive voltages are selected by rotating the card 90° clockwise); insert voltage selector card into housing, *printed side of card facing toward IEC connector* and edge containing the desired voltage first; replace cover and verify that the indicator pin shows the desired voltage.

Voltage selector card orientation is shown in Figure A-II-2.

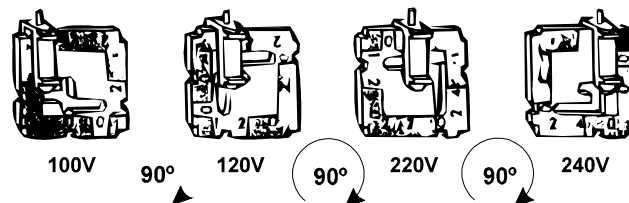


Figure A-II-2

Fuse changing:

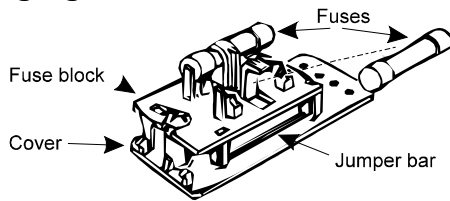


Figure A-II-3a
European fusing arrangement

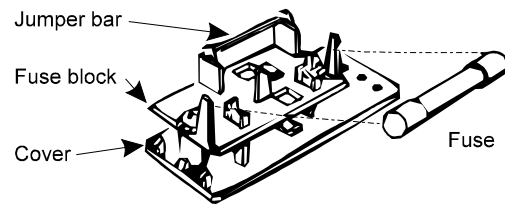


Figure A-II-3b
North American fusing arrangement

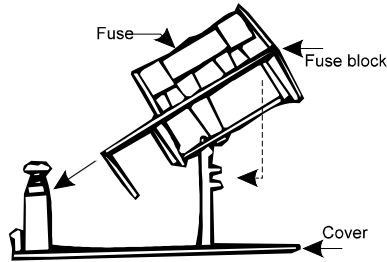


Figure A-II-4
Fuse block/cover assembly

To change from North American to European fusing: open cover using a small blade screwdriver or similar tool; loosen Phillips screw 2 turns; remove fuse block by sliding up, then away from Phillips screw and lifting up from pedestal; change fuses (note that *two* European fuses are required, although a dummy fuse may be used in the neutral [lower] holder); invert fuse block and slide back onto Phillips screw and pedestal; tighten Phillips screw and replace cover (note that the fuse[s] that go into the housing first are the active set.)

See SPECIFICATIONS for recommended fuses.

APPENDIX III

HV BREAKDOWN CONSIDERATIONS

Air is subject to dielectric breakdown when the probe-to-surface spacing is small and the difference in voltage between the probe and the surface under test is high. A destructive arc-over can occur damaging the surface under test and/or the sensitive circuitry of the probe. Under normal operating conditions this is usually not a problem as the probe housing is driven to a voltage essentially identical to the unknown and the difference in voltage is very close to zero.

Under normal circumstances the Model 279 ISOPROBE[®] Electrostatic Voltmeter can follow the unknown voltage up to its high voltage amplifier limits — a few hundred volts above its specified range of ± 3000 volts.

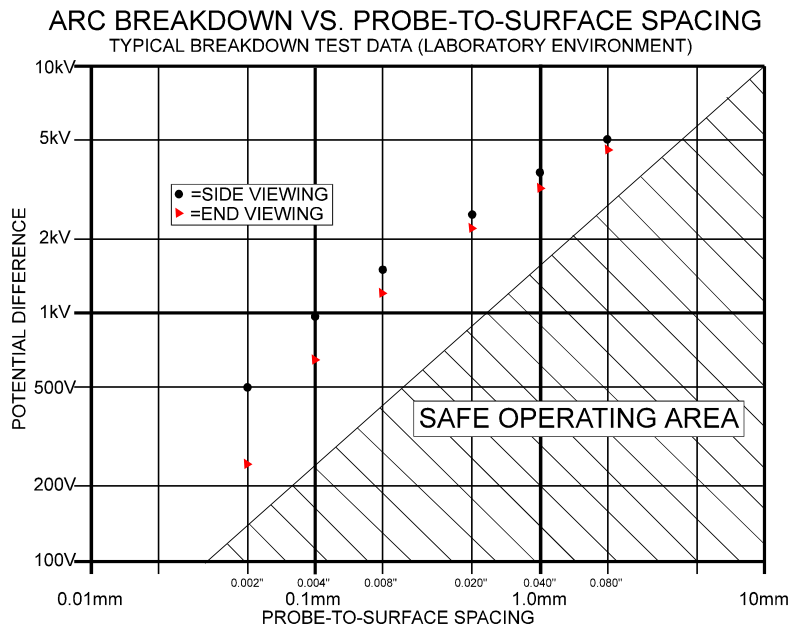


Figure A-II-1

APPENDIX IV

ACHIEVING SPACING INDEPENDENCE

Eliminating Zero Shift Over a Large Probe-to-Surface Spacing Range

This instrument's basic operating principle is to null the electric field between a surface under measurement and the sensitive electrode in the probe. When the potential of the surface under measurement is zero, the instrument drives the sensitive electrode and the probe housing (a reference surface) to zero potential, thereby nulling the electric field between the probe and the surface under measurement.

Ideally, only the surface under measurement contributes to this process. However, if other voltage sources exist in the vicinity of the sensitive electrode, which are independent of the unknown to be measured, offsets are produced. Such voltage sources include contact potential differences among internal probe parts, small specs of charged dust, etc. The ZERO1 control is provided to counter such offsets by applying a voltage directly to the sensitive electrode.

The influence of these voltage sources is usually not the same at all probe-to-surface separations. Their influence will vary in proportion to the probe-to-surface separation and will cause the instrument zero offset voltage to vary with probe-to-surface spacing changes. This effect can be minimized to afford a high degree of zero stability over a range of spacing changes. This is known as spacing independence.

The following procedure is used to optimize the spacing independence of the instrument:

1. Position the probe at the minimum spacing to the surface under test. Apply zero volts to the surface under test.
2. Switch the instrument to the OPERATE mode and adjust the GAIN for a critically damped or somewhat over-damped condition.
3. Adjust the ZERO2 control for a zero output voltage from the instrument.
4. Re-position the probe to the maximum spacing from the surface under test.
5. Adjust the ZERO1 control for a zero output voltage from the instrument.
6. Return the probe to the minimum spacing to the surface under test.
7. Repeat steps 3 through 7 until the zero shift is minimized to the desired level.